

DCN No.	E980005-00-D					
SHEET	1	OF	1			

DOCUME	<b>NT CHANG</b>	E NOTICE	E (DCN)						
DOCUMENT No. (DOC-REV-GP. ID)									
E960093-B-D	Substrate, Input	Test Mass			С				
	, 1								
CHANGE DESCRIPTION (FROM/T	O):								
Specification Changes in	corporated in E96	50093-C-D Sub	strate, Input Test Ma	SS					
Revise the Input Test Mass	s side 1 radius fro	m 14570 meter	s (no thermal lensing	) to 14180 meters	s +140/ -1000				
meters (+1%, -7% as before			,	,					
Revise the side 1 reflected	_				•				
wavelength of test) or 14180/1.45552 or 9,740 meters. The wavelength of test is 690 nanometers.									
REASON FOR CHANGE: Change	ge Radius of Curv	ature for Therr	nal Lensing compens	ation.					
ACTION: Incorporate chang	e Attach DCN t	to drawing(s)	Other action (specify):						
	OF HARDWARE (IDEN	TIFY SERIAL NUME	BERS)	DCN DISTRIBUTIO	N (X=incl. docs)				
No hardware affected (reco				Althouse Barish					
List S/Ns which comply alre				Raab Sande	ers Shoemaker				
List S/Ns to be reworked or scrapped:  Stapfer Tyler W. Whitcomb Zydowicz									
List S/Ns to be built with thi									
List S/Ns to be retested per this change:  Camp									
☐ Kells Elieson									
Petrac									
SAFETY, COST, SCHEDULE, REG	DUIREMENTS IMPACT	? X No Y	es (If yes, enter Change Re	equest number	<u> </u>				
APPROVALS		DATE	OTHER APPROVA	-	DATE				
ORIGINATOR: Billingsley		1/28/98		- ()					
TASK LEADER:		1,20,70							
GROUP LEADER:									
DCC RELEASE:									